

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/591,976 ROSSMANN ET AL.	
		Examiner	Art Unit KENNETH J. WHITTINGTON	2858 Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,752,733	06-1988	Petr et al.	324/225
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	K	US-			
	L	US-			
	M	US-			

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	U	Demierre, Michel, IMPROVEMENTS OF CMOS HALL MICROSYSTEMS AND APPLICATIONS FOR ABSOLUTE ANGULAR POSITION MEASUREMENTS, University These for Institute of Microelectronics and Microsystems, dated September 2003.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.